

# **Excellent Integrated System Limited**

Stocking Distributor

Click to view price, real time Inventory, Delivery & Lifecycle Information:

Maxim Integrated MAX3873AETP+

For any questions, you can email us directly: sales@integrated-circuit.com

**Features** 







# Low-Power, Compact 2.5Gbps/2.7Gbps Clock-Recovery and Data-Retiming IC

#### **General Description**

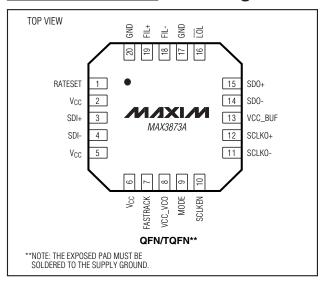
The MAX3873A is a compact, low-power 2.488Gbps/ 2.67Gbps clock-recovery and data-retiming IC for SDH/SONET applications. The phase-locked loop (PLL) recovers a synchronous clock signal from the serial NRZ data input. The input data is then retimed by this recovered clock, providing a clean data output. The MAX3873A meets all SDH/SONET jitter specifications, does not require an external reference clock to aid in frequency acquisition, and provides excellent tolerance to both deterministic and sinusoidal jitter. The MAX3873A provides a PLL loss-of-lock (LOL) output to indicate whether the CDR is in lock. The recovered data and clock outputs are CML with on-chip  $50\Omega$  back terminations on each line. The clock output can be powered down if not used.

The MAX3873A is implemented in Maxim's second-generation SiGe process and consumes only 260mW at 3.3V supply (output clock disabled, low output swing). The device is available in a 4mm x 4mm 20-pin QFN exposed-pad package and operates from -40°C to +85°C.

### **Applications**

Switch Matrix Backplanes SDH/SONET Receivers and Regenerators Add/Drop Multiplexers Digital Cross-Connects SDH/SONET Test Equipment **DWDM Transmission Systems** 

#### Pin Configuration



#### ◆ Fully Integrated Clock Recovery and Data Retiming

- ♦ Power Dissipation: 260mW with +3.3V Supply
- ♦ Clock Jitter Generation: 5mUIRMS
- ♦ Exceeds ANSI, ITU, and Bellcore SDH/SONET **Jitter Specifications**
- ◆ Differential Input Range: 50mVp-p to 1.6Vp-p
- ♦ Single +3.3V Power Supply
- ♦ PLL Fast Track (FASTRACK) Mode Available
- ♦ Clock Output Can Be Disabled
- ♦ Input Data Rate: 2.488Gbps or 2.67Gbps
- ♦ Selectable Output Amplitude
- ♦ Tolerates 2000 Consecutive Identical Digits
- ♦ Loss-of-Lock Indicator
- ♦ Differential CML Data and Clock Outputs
- ♦ Operating Temperature Range: -40°C to +85°C

### **Ordering Information**

PART	TEMP RANGE	PIN- PACKAGE	PKG CODE	
MAX3873AEGP	-40°C to +85°C	20 QFN (4mm x 4mm)	G2044-3	
MAX3873AETP+	-40°C to +85°C	20 TQFN (4mm x 4mm)	T2044-3	

+ Denotes lead-free package.

Typical Application Circuit appears at end of data sheet.

MIXIM

Maxim Integrated Products 1



#### **ABSOLUTE MAXIMUM RATINGS**

Supply Voltage, VCC	0.5V to +5.0V
Voltage at SDI± (VC	$(C - 1.0V)$ to $(V_{CC} + 0.5V)$
CML Output Current at SDO±, SCLKO:	±22mA
Voltage at LOL, FASTRACK, FIL±, SCL	KEN .
MODE, RATESET	0.5V to (VCC + 0.5V)
Continuous Power Dissipation (TA = +8	35°C)
20-Lead QFN (derate 20.0mW/°C at	bove +85°C)1300mW

Operating Temperature Range	40°C to +85°C
	50°C to +150°C
0 1	+400°C
	10s)+300°C
Lead remperature (soldering,	103)T000 O

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### DC ELECTRICAL CHARACTERISTICS

 $(V_{CC} = 3.0 \text{V to } 3.6 \text{V}, T_A = -40 ^{\circ}\text{C to } +85 ^{\circ}\text{C}. \text{ Typical values are at } 2.488 \text{Gbps}, V_{CC} = 3.3 \text{V}, T_A = +25 ^{\circ}\text{C}, \text{ unless otherwise noted.})$  (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
O		MODE = GND, SCLKEN = low		79	99	
Supply Current (Note 2)	Icc	MODE = OPEN, SCLKEN = high		112 142		mA mA
CML INPUT SPECIFICAT	IONS (SDI+,	SDI-)	•			
Differential Input Voltage	V <sub>ID</sub>	Figure 1	50		1600	mV <sub>P-P</sub>
Single-Ended Input Voltage	VIS	Figure 1	V <sub>CC</sub> - (	0.8	V <sub>CC</sub> + 0.4	V
Input Common-Mode Voltage		DC-coupled, Figure 1	V <sub>CC</sub> - V	<sub>ID</sub> /4		V
Input Termination to V <sub>CC</sub>	RIN		40	50	60	Ω
CML OUTPUT SPECIFICA	ATIONS (SD	O+, SDO-, SCLKO+, SCLKO-)	•			
D'''		MODE = open	640	800	1000	
Differential Output Swing (Note 3)		$MODE = V_{CC}$	400	600	800	mV <sub>P-P</sub>
(14010-0)		MODE = GND	200	400	600	
Differential Output Resistance	Ro		80	100	120	Ω
		MODE = Open		V <sub>CC</sub> - 0.17		
Output Common-Mode Voltage (Note 3)		MODE = V <sub>CC</sub>		V <sub>CC</sub> - 0.13		V
voitage (Note 3)		MODE = GND		V <sub>C</sub> C - 0	.08	
TTL INPUT/OUTPUT SPE	CIFICATION	S (FASTRACK, LOL, SCLKEN, MODE, RATESE	T)			
Input High Voltage	V <sub>IH</sub>		2.0			V
Input Low Voltage	V <sub>IL</sub>				0.8	V
Input Current			-30		+30	μΑ
Output High Voltage	VoH	I <sub>OH</sub> = sourcing 40μA	2.4			V
Output Low Voltage	VOL	I <sub>OL</sub> = sinking 2mA		0.4	V	



#### **AC ELECTRICAL CHARACTERISTICS**

 $(V_{CC} = 3.0 \text{V to } 3.6 \text{V}, C_F = 0.022 \mu\text{F}, T_A = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}.$  Typical values are at  $V_{CC} = 3.3 \text{V}, 2.488 \text{Gbps}, T_A = +25 ^{\circ}\text{C}, \text{ unless otherwise noted.})$  (Note 4)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS	
Serial Input Data Rate		RATESET = lov	V		2.488		Gbps	
Seriai iriput Data hate		RATESET = high			2.67		Gups	
Clock-to-Q Delay	tclk-q	Figure 2 (Note	5)	-70		+70	ps	
Jitter Peaking	JР	f ≤ 2MHz				0.1	dB	
Jitter Transfer Bandwidth	J <sub>BW</sub>	RATESET = Lo	w			2.0	MHz	
		(Notes 6, 8)	f = 70kHz, 0.4UI deterministic jitter on input data		6.9		- Ulp <sub>-</sub> p	
			f = 100kHz, 0.4UI deterministic jitter on input data	2.12	4.5			
			f = 1MHz, 0.4UI deterministic jitter on input data	0.33	0.6			
Sinusoidal Jitter Tolerance			f = 10MHz, 0.4UI deterministic jitter on input data	0.15	0.3			
Siliusoidal siller Tolerance			f = 70kHz, 0.4UI deterministic jitter on input data		6.9			
		(Notes 6, 9)	f = 100kHz, 0.4UI deterministic jitter on input data	2.12	4.5			
			f = 1MHz, 0.4UI deterministic jitter on input data	0.33	0.6			
			f = 10MHz, 0.37UI deterministic jitter on input data	0.15	0.3			
		(Notes 7 0)			5	6.8	mUI <sub>RMS</sub>	
Jitter Generation	JGEN	(Notes 7, 8)			45	62	mUI <sub>P-P</sub>	
Jiller Gerieration	JGEN	(Notes 7, 0)			6	7.65	mUI <sub>RMS</sub>	
		(Notes 7, 9)			40	86	mUI <sub>P-P</sub>	
Clock Output Edge Speed		20% to 80%			60	110	ps	
Data Output Edge Speed		20% to 80%			60	110	ps	
Tolerated Consecutive Identical Digits					2000		bits	
SDI± Input Return Loss		100kHz to 2.5GHz			17		-ID	
(-20log( S <sub>11</sub>  ))		2.5GHz to 4.0GHz			14		dB	
Frequency Acquisition Time		Figure 4			1		ms	
TOL Assert Time		Figure 4			1.6		μs	





### **AC ELECTRICAL CHARACTERISTICS (continued)**

 $(V_{CC} = 3.0 \text{V to } 3.6 \text{V}, C_F = 0.022 \mu\text{F}, T_A = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}.$  Typical values are at  $V_{CC} = 3.3 \text{V}, 2.488 \text{Gbps}, T_A = +25 ^{\circ}\text{C}, \text{ unless otherwise noted.})$  (Note 4)

**Note 1:** At  $T_A = -40$ °C, DC characteristics are guaranteed by design and characterization.

Note 2: CML outputs open.

**Note 3:**  $R_L = 50\Omega$  to  $V_{CC}$ .

Note 4: AC characteristics are guaranteed by design and characterization.

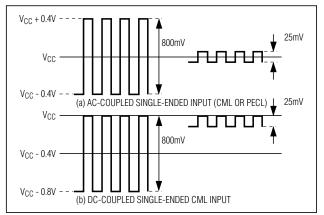
Note 5: Relative to the falling edge of SCLKO+. See Figure 2.

Note 6: Measured with 223 - 1 PRBS.

Note 7: Jitter BW = 12kHz to 20MHz.

Note 8: RATESET = low.

Note 9: RATESET = high.



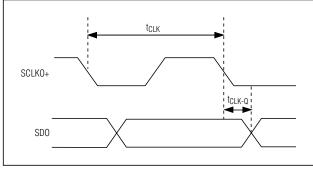


Figure 2. Definition of Clock-to-Q Delay

Figure 1. Definition of Input Voltage Swing

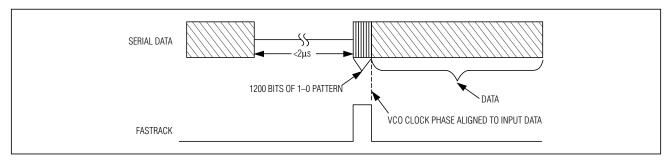


Figure 3. Definition of Phase Acquisition Time

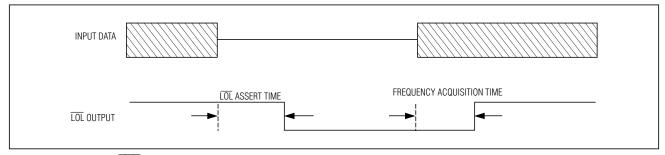
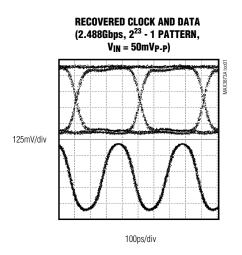


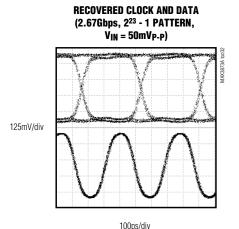
Figure 4. Definition of LOL Assert Time and Frequency Acquisition Time

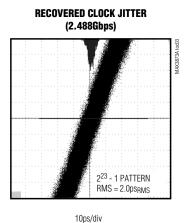


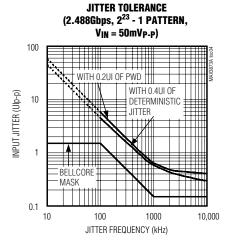
**Typical Operating Characteristics** 

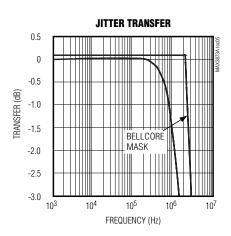
 $(T_A = +25^{\circ}C, \text{ unless otherwise noted.})$ 

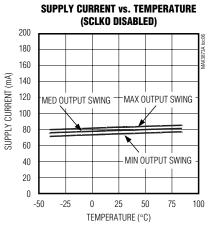


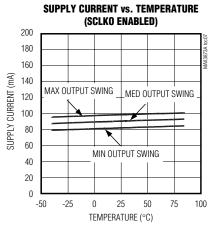








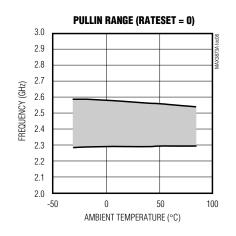


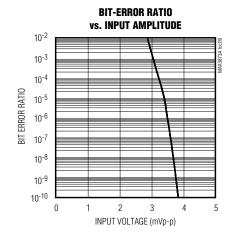


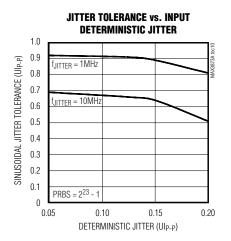


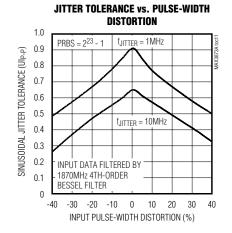
Typical Operating Characteristics (continued)

 $(T_A = +25^{\circ}C, \text{ unless otherwise noted.})$ 









### **Pin Description**

PIN	NAME	FUNCTION	
1	RATESET	Input Rate Select. Connect to TTL low for 2.488Gbps data and to TTL high for 2.67Gbps data.	
2, 5, 6	Vcc	3.3V Supply Voltage	
3	SDI+	Positive Serial Data Input	
4	SDI-	Negative Serial Data Input	
7	FASTRACK	PLL Fast Track Control, TTL Input. When FASTRACK is TTL high, the PLL is switched to a fast-track mode for fast phase acquisition. When FASTRACK is TTL low, the PLL operates normally.	
8	VCC_VCO	3.3V VCO Supply Voltage	
9	MODE	Output Amplitude Mode Select. MODE = open sets the CML output amplitude to high; MODE = high sets the output amplitude to medium; MODE = low sets the output amplitude to low.	

MIXIM



### **Pin Description (continued)**

PIN	NAME	FUNCTION	
10	SCLKEN	Clock Output Enable, TTL Input. When SCLKEN = open or SCLKEN = high, the clock outputs (SCLKO $\pm$ ) are enabled. When SCLKEN = low, the clock outputs are disabled and SCLKO $\pm$ = V <sub>CC</sub> .	
11	SCLKO-	Negative Clock Output, CML. This output can be disabled by setting SCLKEN to low.	
12	SCLKO+	Positive Clock Output, CML. This output can be disabled by setting SCLKEN to low.	
13	VCC_BUF	3.3V CML Output Buffer Supply Voltage	
14	SDO-	Negative Data Output, CML	
15	SDO+	Positive Data Output, CML	
16	LOL	Loss-of-Lock Output, TTL (Active Low). The LOL output indicates a PLL lock failure.	
17, 20	GND	Supply Ground	
18	FIL-	Negative PLL Loop Filter Connection. Connect a 0.022µF capacitor between FIL+ and FIL	
19	FIL+	Positive PLL Loop Filter Connection. Connect a 0.022µF capacitor between FIL+ and FIL	
EP	EP Exposed Pad Ground. The exposed pad must be soldered to the circuit board ground for proper electrical thermal operation.		

### **Detailed Description**

The MAX3873A consists of a fully integrated phase-locked loop (PLL), input amplifier, and CML output buffers (Figure 5). The PLL consists of a phase/frequency detector, a loop filter, and a voltage-controlled oscillator (VCO).

This device is designed to deliver the best combination of jitter performance and power dissipation by using a fully differential signal architecture and low-noise design techniques.

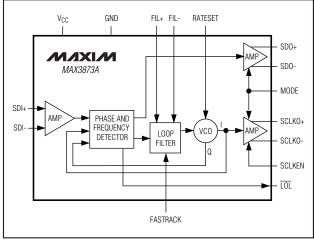


Figure 5. Functional Diagram

#### **Input Amplifier**

The input amplifier provides internal  $50\Omega$  line terminations and can accept a differential input amplitude from 50mVp-p to 1600mVp-p. The structure of the input amplifier is shown in Figure 9.

#### Phase Detector

The phase detector incorporated in the MAX3873A produces a voltage proportional to the phase difference between the incoming data and the internal clock. Because of its feedback nature, the PLL drives the error voltage to zero, aligning the recovered clock to the center of the incoming data eye for retiming.

#### **Frequency Detector**

The digital frequency detector (FD) aids frequency acquisition during startup conditions. The frequency difference between the received data and the VCO clock is derived by sampling the VCO outputs on each edge of the data input signal. The FD drives the VCO until the frequency difference is reduced to zero. Once frequency acquisition is complete, the FD returns to a neutral state.

#### **Loop Filter and VCO**

The phase detector and frequency detector outputs are summed into the loop filter. An external capacitor, CF, is required to set the PLL damping ratio. See the *Design Procedure* section for guidelines on selecting this capacitor.





The loop filter output controls the on-chip LC VCO running at either 2.488GHz or 2.67GHz. The VCO provides low phase noise and is trimmed to the correct frequency. Clock jitter generation is typically 2psrms within a jitter band of 12kHz to 20MHz.

#### **Loss-of-Lock Monitor**

A loss-of-lock ( $\overline{\text{LOL}}$ ) monitor is incorporated in the MAX3873A to indicate either a loss of frequency lock or the absence of incoming data. Under loss-of-lock conditions,  $\overline{\text{LOL}}$  may momentarily assert high due to noise.

### Design Procedure

#### **Setting the Loop Filter**

The MAX3873A is designed for both regenerator and receiver applications. Its fully integrated PLL is a classic second-order feedback system, with a loop bandwidth (JBW) below 2.0MHz. The external capacitor, CF, can be adjusted to set the loop damping. Figures 6 and 7 show the open-loop and closed-loop transfer functions. The PLL zero frequency, fz, is a function of external capacitor CF and can be approximated according to:

$$f_Z = \frac{1}{2\pi (3000\Omega) C_F}$$

with CF expressed in F.

For an overdamped system, the jitter peaking (JP) of a second-order system can be approximated by:

$$J_{P} = 20log \left(1 + \frac{f_{Z}}{J_{BW}}\right)$$

For example, using CF = 2000pF results in jitter peaking of 0.2dB. Reducing CF below 500pF might result in PLL instability. The recommended value is CF =  $0.022\mu\text{F}$  to guarantee a maximum jitter peaking of less than 0.1dB. CF must be a low TC, high-quality capacitor of type X7R or better.

#### **FASTRACK Mode**

The MAX3873A has a PLL fast-track (FASTRACK) mode to decrease locking time in switched data applications. In applications where the input data is switched from one source to another, there is a brief period in which there is no valid data input to the MAX3873A. In the absence of input data, the PLL phase slowly drifts from the ideal position. By enabling FASTRACK during reacquisition, the time required to regain phase alignment is reduced. This is accomplished by increasing the loop bandwidth by approximately 50%.

The bandwidth of the MAX3873A is also linearly dependent upon the transition density of the input data. By using a preamble of 1200 bits of a 1–0 pattern during switching, the loop bandwidth is increased by a factor of approximately 2 (Figure 3). Thus, by using a 1–0 pattern preamble and enabling FASTRACK, the PLL bandwidth is increased by a factor of approximately 3, resulting in the fastest possible reacquisition of phase lock.

FASTRACK increases the rate at which the MAX3873A acquires the proper phase, assuming that the VCO is already running at the proper frequency. On startup conditions, however, the VCO frequency is significantly different from the input data, and the time required to lock to the incoming data is increased to approximately 1.0ms.

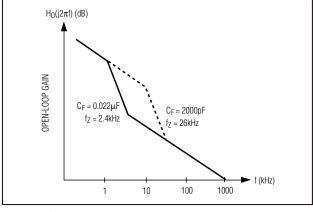


Figure 6. Open-Loop Transfer Function

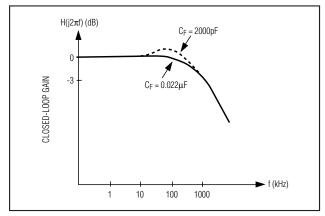


Figure 7. Closed-Loop Transfer Function



#### Sinusoidal Jitter Tolerance and Input Deterministic Jitter Trade-Offs

The MAX3873A has excellent jitter tolerance. Adding DJ to the input will close the eye opening and result in reduced sinusoidal jitter tolerance. It typically can tolerate more than 0.3UIP-P of 10MHz jitter when measured with a 2<sup>23</sup> - 1 PRBS data stream with 0.4UI of deterministic jitter (DJ). This gives a total high-frequency jitter tolerance of 0.7UI. Refer to the Jitter Tolerance vs. Pulse-Width Distortion and Jitter Tolerance vs. Deterministic Jitter graphs in the *Typical Operating Characteristics* section.

#### **Input and Output Terminations**

The MAX3873A's digital CML outputs (SDO+, SDO-, SCLKO+, SCLKO-) have selectable output amplitude controlled by the MODE input. If the SCLKO outputs are not used, they can be disabled (see the Supply Current vs. Temperature graph in the *Typical Operating Characteristics* section).

The structure of the high-speed digital outputs is shown in Figure 8. The MODE input sets the current in the current source, thereby controlling the output swing. The SCLKEN input sets the current in the SCLKO current source to 0mA, disabling the output.

The structure of the CML inputs (SDI±) is shown in Figure 9. Unless the CML input is DC-coupled to a CML output, use AC-coupling with the CML inputs to avoid upsetting the common-mode voltage.

## \_Applications Information

#### **Consecutive Identical Digits (CID)**

The MAX3873A has a low phase and frequency drift in the absence of data transitions. As a result, long runs of consecutive zeros and ones can be tolerated while maintaining a BER of less than  $10^{-10}$ . The CID tolerance is tested using a  $2^{13}$  - 1 PRBS, substituting a long run of zeros to simulate the worst case. A CID tolerance of 2000 bits is typical.

#### **Exposed-Pad Package**

The exposed-pad (EP), 20-pin QFN incorporates features that provide a very low thermal-resistance path for heat removal from the IC. The pad is electrical ground on the MAX3873A and must be soldered to the circuit board for proper thermal and electrical performance.

#### Layout

Circuit board layout and design can significantly affect the MAX3873A's performance. Use good high-frequency design techniques, including minimizing ground inductance and using controlled-impedance transmission lines on the data and clock signals. Place power-supply decoupling as close to the VCC pins as possible. Isolate the input from the output signals to reduce feedthrough.

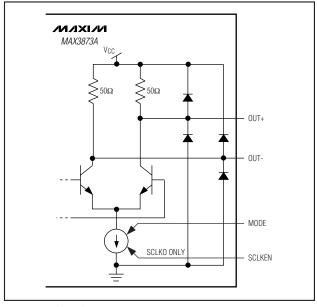


Figure 8. CML Output Model

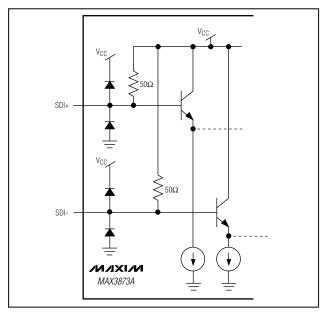
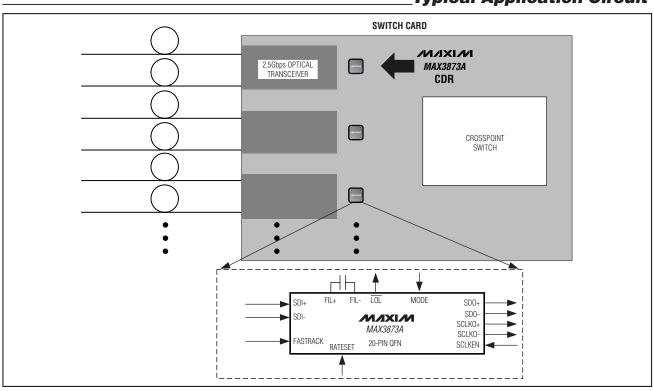


Figure 9. CML Input Model





### **Typical Application Circuit**



### **Chip Information**

TRANSISTOR COUNT: 2028

TRANSISTOR COUNT: 2028
PROCESS: SiGe BiCMOS

## \_Package Information

For the latest package outline information, go to www.maxim-ic.com/packages.

PACKAGE TYPE	DOCUMENT NO.
20 QFN	<u>21-0106</u>
20 Thin QFN	<u>21-0139</u>

#### **Revision History**

Rev 0; 9/02: Initial data sheet release.

Rev 1; 5/03: Added package code to Ordering Information table (page 1), updated Package Information

(pages 11, 12).

Rev 2; 5/07: Added lead-free package to Ordering Information table (page 1).

Maxim cannot assume responsibility for use of any circuitry other than circuitry entirely embodied in a Maxim product. No circuit patent licenses are implied. Maxim reserves the right to change the circuitry and specifications without notice at any time.

10 \_\_\_\_\_\_Maxim Integrated Products, 120 San Gabriel Drive, Sunnyvale, CA 94086 408-737-7600

© 2007 Maxim Integrated Products

is a registered trademark of Maxim Integrated Products.